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STANDAI MILIT DRAV	AR	Y	D	_ - -	CHECKED BY CHECKED BY CHARLES E. BESOLL APPROVED BY				DEFENSE ELECTRONICS SUPPLY CENTER DAYTON, OHIO 45444 MICROCIRCUITS, LINEAR, WIDEBAND RMS-TO-DC			ОС												
THIS DRAWING FOR USE BY ALL AND AGENC	IS A	VAILA ARTN	IENT			WING	APF	PROV	_		e		+	CONVERTER, MONOLITHIC SILICON SIZE CAGE CODE										
DEPARTMENT				f	REV	ISION	FEBF LEV		1 15	990			A 67268 5962-89637											

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5962-E1491

DISTRIBUTION STATEMENT A. Approved for public release; distribution is unlimited.

										
1. SCOPE										
1.1 Scope. This drawing describes devi with 1.2.1 of MIL-STD-883, "Provisions for non-JAN devices".	ice requir r the use	ements of MIL-	for class B m STD-883 in co	icrocircui onjunction	ts in accordance with compliant					
1.2 Part number. The complete part num	mber shall	be as	shown in the	following	example:					
<u>5962-89637</u> <u>01</u>	-		<u>c</u>		<u>x</u> 					
Drawing number Device (1.2		Ca	 se outline (1.2.2)		j d finish per IIL-M-38510					
1.2.1 Device type. The device type sha	all identi	fy the	circuit funct	ion as fol	lows:					
Device type Generic num	mber		Circuit fur	ction						
01 AD637		W	lideband RMS-1	co-DC conve	rter					
1.2.2 <u>Case outline</u> . The case outline shall be as designated in appendix C of MIL-M-38510, and as follows:										
Outline letter			Case outli							
С	D-1 (14-1	ead, .7	'85" x .310" x	.200"), d	ual-in-line package					
1.3 Absolute maximum ratings.										
Positive supply voltage (+V _S) Negative supply voltage (-V _S) Output short circuit duration Storage temperature range Lead temperature (soldering, 10 secon Internal quiescent power dissipation Thermal resistance, junction-to-case Thermal resistance, junction-to-ambigunction temperature (T _J)	onds) e (θ _{JC}) ient (θ _{JA})		-18 V dc Indefinite -65°C to 4 +300°C 108 mW See MIL-M-	150°C 38510, app	endix C					
1.4 Recommended operating conditions.										
Positive supply voltage (+ V_S) Negative supply voltage (- V_S) Ambient operating temperature range			-15 V dc	·125°C						
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2. APPLICABLE DOCUMENTS

2.1 Government specification, standard, and bulletin. Unless otherwise specified, the following specification, standard, and bulletin of the issue listed in that issue of the Department of Defense Index of Specifications and Standards specified in the solicitation, form a part of this drawing to the extent specified herein.

SPECIFICATION

MILITARY

MIL-M-38510

Microcircuits, General Specification for.

STANDARD

MILITARY

MIL-STD-883

Test Methods and Procedures for Microelectronics.

BULLETIN

MILITARY

MIL-BUL-103

- List of Standardized Military Drawings (SMD's).

(Copies of the specification, standard, and bulletin required by manufacturers in connection with specific acquisition functions should be obtained from the contracting activity or as directed by the contracting activity.)

- 2.2 Order of precedence. In the event of a conflict between the text of this drawing and the references cited herein, the text of this drawing shall take precedence.
 - 3. REQUIREMENTS
- 3.1 Item requirements. The individual item requirements shall be in accordance with 1.2.1 of MIL-STD-883, "Provisions for the use of MIL-STD-883 in conjunction with compliant non-JAN devices" and as specified herein.
- 3.2 <u>Design, construction, and physical dimensions</u>. The design, construction, and physical dimensions shall be as specified in MIL-M-38510 and herein.
 - 3.2.1 Terminal connections. The terminal connections shall be as specified on figure 1.
 - 3.2.2 Functional block diagram. The functional block diagram shall be as specified on figure 2.
 - 3.2.3 Case outline. The case outline shall be in accordance with 1.2.2 herein.
- 3.3 Electrical performance characteristics. Unless otherwise specified herein, the electrical performance characteristics are as specified in table I and shall apply over the full ambient operating temperature range.
- 3.4 <u>Electrical test requirements</u>. The electrical test requirements shall be the subgroups specified in table II. The electrical tests for each subgroup are described in table I.
- 3.5 <u>Marking</u>. Marking shall be in accordance with MIL-STD-883 (see 3.1 herein). The part shall be marked with the part number listed in 1.2 herein. In addition, the manufacturer's part number may also be marked as listed in MIL-BUL-103 (see 6.6 herein).

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TABLE I. Electrical performance characteristics. Group A Limits Unit Symbol | Conditions Test +V_S = +15 V, -V_S = -15 V -55°C < T_A < +125°C unless otherwise specified subgroups Min Max | V_{IN} = 0 V to ± 10 V 1 1/ Total error ET 2,3 1/ 1,2,3 ±150 µV/V +5.0 V < +Vs < +15 V Total error vs. ΔEŢ positive supply A+Vs ±300 | µY/Y 1 |-5.0 V < -V_S < -15 V Total error vs. ΔET negative supply Δ-V_S ±500 2,3 |±.25 | % of $V_{IN} = \pm 2.0 \text{ V, } T_A = \pm 25^{\circ}\text{C}$ 1 ETR DC reversal error reading % of 2.0 V fullscale nonlinearity ±.04 NL₁ 10 mV < V_{OUT} < 2.0 V 1 ±0.06 2,3 % of ±.05 | 7.0 V fullscale NL2 1 10 mV < VOUT < 7.0 V nonlinearity ±.14 2,3 m٧ 1 **±1.0** | Output offset V_{OSO} VIN = GND voltage ***6.0** 2,3 2,3 ±0.07 | mV/°C ∆V_{OSO} Ouput offset voltage VIN = GND temperature ΔΤ coefficient ٧ $R_L = 2.0 k\Omega$ 1,2,3 112 Output voltage swing V_{OP} at RMS OUT See footnotes at end of table. **STANDARDIZED** SIZE Α 5962-89637 MILITARY DRAWING **DEFENSE ELECTRONICS SUPPLY CENTER REVISION LEVEL** SHEET DAYTON, OHIO 45444

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TADLE 1.	Liectrica	al performance characteristics -	Continued.				
Test					its	l Unit 	
	<u> </u>	-55°C < TA < +125°C unless otherwise specified	 	Min Max		<u> </u>	
I _{REF} O for O dB = 1.0 V rms	I _{REF1}	T _A = +25°C	1	5.0	80	 μΑ 	
I _{REF} range <u>2</u> /	IREF2	T _A = +25°C	1 1	1.0	100	μA	
Buffer input offset voltage	V _{0S2}	T _A = +25°C	1 1		±2.0	l mV	
Buffer input current	IIIN	 T _A = +25°C	1 1		±10	l nA	
Denominator input resistance 2/	 Rden 	 T _A = +25°C 	4	20	 30 	 k Ω 	
Denominator input offset voltage 2/	V _{OS3}	T _A = +25°C	1		±0.5	mV	
Power supply range	٧s	T _A = +25°C	1 1	±3.0	±18	 V 	
Quiescent current	IQ	VS = ±18 V	1,2,3		13.0	mA	
Standby current	ISB	Y _{CS} < 0.2 V, T _A = +25°C	1 1		 450	μA	

I/ For subgroup 1, the maximum total error is ±1.0 mV ±0.5% of reading. For subgroups 2 and 3, the maximum total error is ±6.0 mV ±0.7% of reading. Total error represents the maximum deviation of the dc component of the output voltage from the theoretical output value over a specified range of signal amplitude and frequency. It is shown as the sum of a fixed error and a component proportional to the theoretical output (percentage of reading). It is specified for a sinusoidal input in a given frequency and amplitude range. The fixed error component includes all offset errors and irreducible nonlinearities; the percentage of reading component includes the linear scale-factor error.

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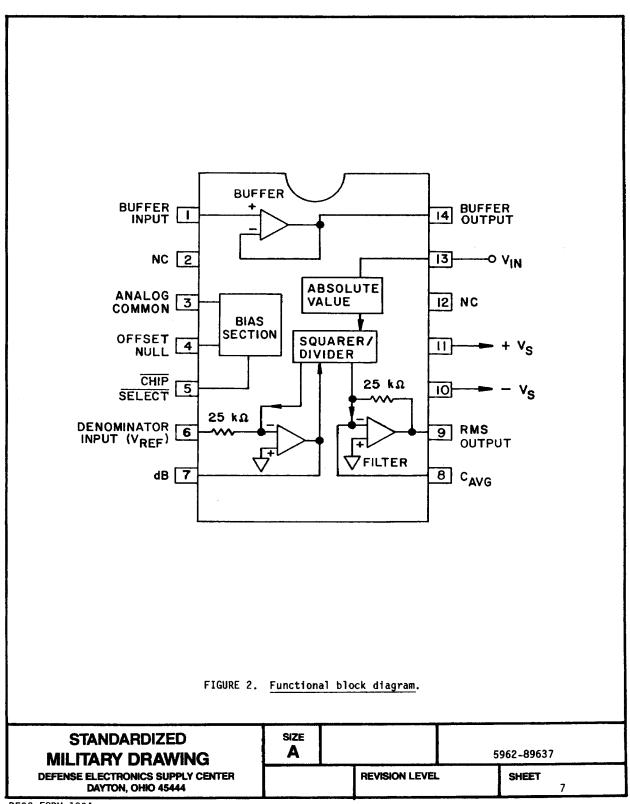
 $[\]underline{2}$ / If not tested, shall be guaranteed to the limits specified in table I.

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Device	type		D1			
Case o			С			
Termina			al symbol			
	1 2 3 4 5 6 7 8 9 10	CS V _{RE} I	ON SET NULL			
	12 13 14	NC VIN BUF	OUT			
<u>i</u>	connection					
FIGURE 1	. <u>Termir</u>		nections.			
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- 3.6 Certificate of compliance. A certificate of compliance shall be required from a manufacturer in order to be listed as an approved source of supply in MIL-BUL-103 (see 6.6 herein). The certificate of compliance submitted to DESC-ECS prior to listing as an approved source of supply shall affirm that the manufacturer's product meets the requirements of MIL-STD-883 (see 3.1 herein) and the requirements herein.
- 3.7 Certificate of conformance. A certificate of conformance as required in MIL-STD-883 (see 3.1 herein) shall be provided with each lot of microcircuits delivered to this drawing.
- 3.8 Notification of change. Notification of change to DESC-ECS shall be required in accordance with MIL-STD-883 (see 3.1 herein).
- 3.9 Verification and review. DESC, DESC's agent, and the acquiring activity retain the option to review the manufacturer's facility and applicable required documentation. Offshore documentation shall be made available onshore at the option of the reviewer.
 - 4. QUALITY ASSURANCE PROVISIONS
- 4.1 Sampling and inspection. Sampling and inspection procedures shall be in accordance with section 4 of MIL-M-38510 to the extent specified in MIL-STD-883 (see 3.1 herein).
- 4.2 Screening. Screening shall be in accordance with method 5004 of MIL-STD-883, and shall be conducted on all devices prior to quality conformance inspection. The following additional criteria shall apply:
 - a. Burn-in test, method 1015 of MIL-STD-883.
 - (1) Test condition A, B, C, or D using the circuit submitted with the certificate of compliance (see 3.6 herein).
 - (2) $T_A = +125^{\circ}C$, minimum.
 - b. Interim and final electrical test parameters shall be as specified in table II herein, except interim electrical parameter tests prior to burn-in are optional at the discretion of the manufacturer.
- 4.3 Quality conformance inspection. Quality conformance inspection shall be in accordance with method 5005 of MIL-STD-883 including groups A, B, C, and D inspections. The following additional criteria shall apply.
 - 4.3.1 Group A inspection.
 - a. Tests shall be as specified in table II herein.
 - b. Subgroups 5, 6, 7, 8, 9, 10, and 11 in table I, method 5005 of MIL-STD-883 shall be omitted.
 - 4.3.2 Groups C and D inspections.
 - a. End-point electrical parameters shall be as specified in table II herein.
 - b. Steady-state life test conditions, method 1005 of MIL-STD-883.
 - Test condition A, B, C, or D using the circuit submitted with the certificate of compliance (see 3.6 herein).
 - (2) $T_A = +125^{\circ}C$, minimum.
 - (3) Test duration: 1,000 hours, except as permitted by method 1005 of MIL-STD-883.

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TABLE II. Electrical test requirements.

MIL-STD-883 test requirements	Subgroups (per method 5005, table I)
 Interim electrical parameters (method 5004)	1
 Final electrical test parameters (method 5004)	1*,2,3
 Group A test requirements (method 5005)	1,2,3,4**
 Groups C and D end-point electrical parameters (method 5005)	1

*PDA applies to subgroup 1.
**Subgroup 4, if not tested, shall be guaranteed to
the limits specified in table I herein.

5. PACKAGING

5.1 Packaging requirements. The requirements for packaging shall be in accordance with MIL-M-38510.

6. NOTES

- 6.1 <u>Intended use</u>. Microcircuits conforming to this drawing are intended for use when military specifications do not exist and qualified military devices that will perform the required function are not available for OEM application. When a military specification exists and the product covered by this drawing has been qualified for listing on QPL-38510, the device specified herein will be inactivated and will not be used for new design. The QPL-38510 product shall be the preferred item for all applications.
- 6.2 Replaceability. Microcircuits covered by this drawing will replace the same generic device covered by a contractor-prepared specification or drawing.
- 6.3 <u>Configuration control of SMD's</u>. All proposed changes to existing SMD's will be coordinated with the users of record for the individual documents. This coordination will be accomplished in accordance with MIL-STD-481 using DD Form 1693, Engineering Change Proposal (Short Form).
- 6.4 Record of users. Military and industrial users shall inform Defense Electronics Supply Center when a system application requires configuration control and the applicable SMD. DESC will maintain a record of users and this list will be used for coordination and distribution of changes to the drawings. Users of drawings covering microelectronics devices (FSC 5962) should contact DESC-ECS, telephone (513) 296-6022.
- 6.5 Comments. Comments on this drawing should be directed to DESC-ECS, Dayton, Ohio 45444, or telephone (513) 296-5375.

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6.6 Approved source of supply. An approved source of supply is listed in MIL-BUL-103.

Additional sources will be added to MIL-BUL-103 as they become available. The vendor listed in MIL-BUL-103 has agreed to this drawing and a certificate of compliance (see 3.6 herein) has been submitted to and accepted by DESC-ECS. The approved source of supply listed below is for information purposes only and is current only to the date of the last action of this document.

Military drawing part number	Vendor CAGE number	Vendor similar part number 1/
5962-8963701CX	24355	AD637SD/8838

1/ Caution. Do not use this number for item acquisition. Items acquired to this number may not satisfy the performance requirements of this drawing.

Vendor CAGE number Vendor name and address

24355

Analog Devices Route 1 Industrial Park P.O. Box 9106 Norwood, MA 02062

Mormood, MA 02062 Point of contract: 804 Woburn Street Wilmington, MA 01887

STANDARDIZED
MILITARY DRAWING

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